

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 07977-150003	Application No. 09/696,863
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Yamazaki, et al.			
		Filing Date October 25, 2000	Group Art Unit 2881		

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
115	AA	6,160,262	12/12/2000	Aoki et al.			
	AB						
	AC						
	AD						
	AE						
	AF						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes No
115	AG	08-077961	03/22/1996	Japan			X
115	AH	63-157868	06/30/1988	Japan			ABS
115	AI	04-104441	04/03/1992	Japan			ABS
115	AJ	05-082083	04/02/1993	Japan			ABS
115	AK	05-128984	05/25/1993	Japan			ABS
115	AL	07-161337	06/23/1995	Japan			ABS
115	AM	64-001455	01/06/1989	Japan			X
115	AN	06-060099	08/19/1994	Japan			X

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
115	AO	M. Naito et al. "High Current Ion Implantation System for Research Use, PR-200A-RD", The Nissin Electric Review, Vol. 35, No. 2, 1990, pp. 25-31
115	AP	N. Nagai et al. "New Generation Parallel Beam Implanter EXCEED 2000", The Nissin Electric Review, Vol. 39, No. 3, 1994, pp. 9-18
	AQ	
	AR	

Examiner Signature <i>Melinda Kella</i>	Date Considered <i>May 16, 2003</i>
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	AK					

Foreign Patent Documents or Published Foreign Patent Applications							Translation	
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
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AM	06-291073	10/18/94	Japan				Abstract only	
AN	07-007060	1/31/95	Japan				Concise Statement	
AO	09-298043	11/18/97	Japan				Abstract only	
AP								

Other Documents (include Author, Title, Date, and Place of Publication)		
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	AR	
	AS	

Examiner Signature <i>Nicole Ralls</i>	Date Considered <i>May 16, 2003</i>
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